

Crystal Oscillator / Clock Generator with optional SSC

FEATURES

- Part of a Family of Easy to use Clock Generator Devices With Optional SSC
- Crystal Oscillator With Integrated Crystal Capacitors, Selectable Output Frequency and Selectable SSC
- SSC Controllable via 2 External Pins
 - $\pm 0\%$, $\pm 0.5\%$, $\pm 1\%$, $\pm 2\%$ Center Spread
- Frequency Multiplication Selectable Between x1 or x4 With one External Control Pin
- Single 3.3V Device Power Supply
- Wide Temperature Range -40°C to 85°C
- Low space Consumption by 8 pin TSSOP Package

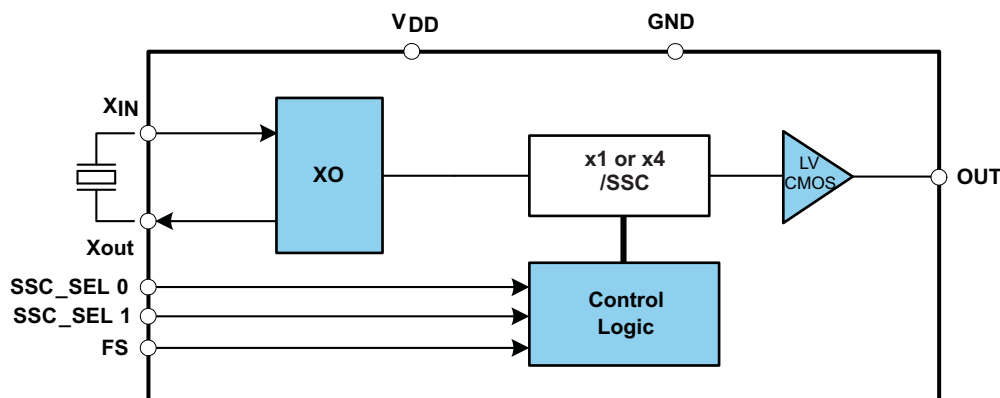
APPLICATIONS

- Consumer and Industrial Applications requiring Crystal Oscillator with the possibility of EMI reduction through Spread Spectrum Clocking

PACKAGE

X _{IN}	1	8	X _{OUT}
SSC_SEL 0	2	7	VDD
SSC_SEL 1	3	6	OUT
GND	4	5	FS

BLOCK DIAGRAM



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION

The CDCS502 is a spread spectrum capable, fundamental mode crystal oscillator with selectable frequency multiplication.

It features an advanced gain controlled fundamental mode crystal oscillator stage with a built-in load capacitance of 10pF. This oscillator stage accepts crystals from 8MHz to 32MHz with an ESR of up to 180Ω. The stage can be used with crystals with power dissipation of 50μW and up.

The input signal is processed by a PLL, whose output frequency is either equal to the input frequency or multiplied by the factor of 4.

The PLL is also able to spread the clock signal by ±0%, ±0.5%, ±1% or ±2% centered around the output clock frequency with an triangular modulation.

By this, the device can generate output frequencies between 8MHz and 108MHz with or without SSC from a fundamental mode crystal.

In x1 Mode with an SSC amount of 0%, the device works as a standard crystal oscillator and does not make use of the built in PLL.

The CDCS502 operates in 3.3V environment.

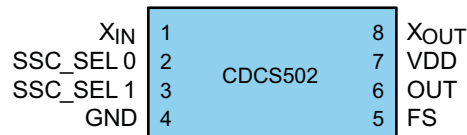
It is characterized for operation from –40°C to 85°C. It is offered in an 8 Pin TSSOP package.

FUNCTION TABLE

FS	SSC_SEL 0	SSC_SEL 1	SSC Amount	f _{OUT} /f _{IN}	f _{OUT} at f _{in} = 27 MHz
0	0	0	±0.00%	1	27 MHz ⁽¹⁾
0	0	1	±0.50%	1	27 MHz
0	1	0	±1.00%	1	27 MHz
0	1	1	±2.00%	1	27 MHz
1	0	0	±0.00%	4	108 MHz
1	0	1	±0.50%	4	108 MHz
1	1	0	±1.00%	4	108 MHz
1	1	1	±2.00%	4	108 MHz

(1) In this mode the signal from the crystal bypasses the internal PLL for maximum performance.

PACKAGE



PIN FUNCTIONS

SIGNAL	PIN	TYPE	DESCRIPTION
X _{IN}	1	I	Crystal Input
X _{OUT}	8	O	Crystal Output
OUT	6	O	LVC MOS Clock Output
SSC_SEL 0, 1	2, 3	I	Spread Selection Pins, internal pull-up
FS	5	I	Frequency Multiplication Selection, internal pull-up
V _{DD}	7	Power	3.3V Power Supply
GND	4	Ground	Ground

PACKAGE THERMAL RESISTANCE FOR TSSOP (PW) PACKAGE⁽¹⁾

CDCV304PW 8-PIN TSSOP			THERMAL AIR FLOW (CFM)				UNIT
			0	150	250	500	
R _{θJA}	High K		149	142	138	132	°C/W
R _{θJA}	Low K		230	185	170	150	°C/W
R _{θJC}	High K	65					°C/W
R _{θJC}	High K	69					°C/W

(1) The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

		VALUE	UNIT
V _{DD}	Supply voltage range	-0.5 to 4.6	V
V _{IN}	Input voltage range	-0.5 to 4.6	V
V _{out}	Output voltage range	-0.5 to 4.6	V
I _{IN}	Input current (V _I < 0, V _I > V _{DD})	±20	mA
I _{out}	Continuous output current	±50	mA
T _{ST}	Storage temperature range	-65 to 150	°C
T _J	Maximum junction temperature	125	°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V _{DD}	Supply voltage	3.0		3.6	V
f _{IN}	Input Frequency	8		32	MHz
V _{IL}	Low level input voltage LVCMOS			0.3 V _{DD}	V
V _{IH}	High level input voltage LVCMOS	0.7 V _{DD}			V
V _I	Input Voltage threshold LVCMOS		0.5 V _{DD}		V
C _L	Output Test Load LVCMOS			10	pF
I _{OH} /I _{OL}	Output Current			12	mA
T _A	Operating free-air temperature	-40		85	°C

RECOMMENDED CRYSTAL SPECIFICATIONS⁽¹⁾

PARAMETER	CONDITIONS	MIN	NOM	MAX	UNIT
f _{X-tal}	FS = 0	8		32	MHz
	FS = 1	8		27	
ESR	Effective series resistance ⁽²⁾			180	Ω
C _L	On-chip load capacitance at Xin and Xout		10		pF
T _{X-tal}	Crystal power dissipation	50			μW

(1) For further details on the crystal, see the crystal part in the Applications section

(2) With 5 pF crystal package parallel capacitance

DEVICE CHARACTERISTICS

over operating free-air temperature range (unless otherwise noted)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT	
IDD	Device supply current	f _{out} = 20 MHz; FS = 0, no SSC		8	mA	
		f _{out} = 20 MHz; FS = 0, SSC = 2%		18		
		f _{out} = 70 MHz; FS = 1, SSC = 2%		22		
f _{OUT}	Output frequency	FS = 0		8	32	MHz
		FS = 1		32	108	MHz
I _{IH}	LVC MOS input current	V _I = VDD; VDD = 3.6 V			10	μA
I _{IL}	LVC MOS input current	V _I = 0 V; VDD = 3.6 V			-10	μA
V _{OH}	LVC MOS high-level output voltage	I _{OH} = -0.1 mA		2.9	V	
		I _{OH} = - 8 mA		2.4		
		I _{OH} = -12 mA		2.2		
V _{OL}	LVC MOS low-level output voltage	I _{OL} = 0.1 mA			0.1	V
		I _{OL} = 8 mA			0.5	
		I _{OL} = 12 mA			0.8	
t _{jit(CC)}	Cycle to cycle jitter	f _{out} = 108 MHz; FS = 1, SSC = 1%, 10000 Cycles			100	ps
t _r /t _f	Rise and fall time	20%–80%			0.75	ns
O _{dc}	Output duty cycle	PLL active		45%	55%	
f _{MOD}	Modulation frequency			30		kHz

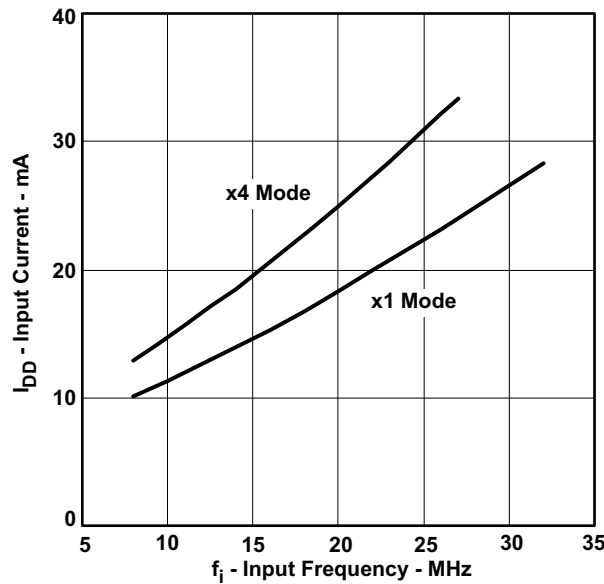


Figure 1. IDD vs Input Frequency, VCC = 3.3V, SSC = 2%



Figure 2. Phase Noise Plot, x1 Mode, 0% SSC, 27 MHz Crystal

APPLICATION INFORMATION

SELECTION OF A CRYSTAL

The CDCS502 requires a crystal with a frequency between 8 and 32 MHz (27MHz in x4 Mode). The crystal stage is designed with an internal load capacitance of 10pF for crystals with this shunt load capacitance. If a slightly bigger capacity than 10pF is needed, small external capacitors can be used to get to this value. This solution however might influence the power-up behavior of the crystal stage, so using a 10pF load capacitance crystal is highly recommended.

For further details on capacitive load calculation, see application report ([SCAA085](#)).

NOTE:

Even though the CDCS502 is characterized down to -40°C , a standard crystal is usually not rated for operation at this low temperature.

SSC MODULATION

The exact implementation of the SSC modulation plays a vital role for the EMI reduction. The CDCS502 uses a triangular modulation scheme implemented in a way that the modulation frequency depends on the VCO frequency of the internal PLL and the spread amount is independent from the VCO frequency.

The modulation frequency can be calculated by using one of the below formulas chosen by frequency multiplication mode.

$$\text{FS} = 0: f_{\text{mod}} = f_{\text{IN}} / 708$$

$$\text{FS} = 1: f_{\text{mod}} = f_{\text{IN}} / 620$$

PARAMETER MEASUREMENT INFORMATION

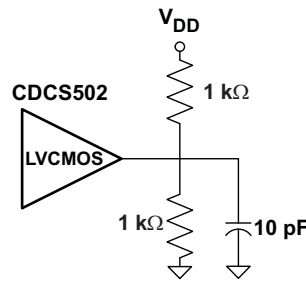


Figure 3. Test Load

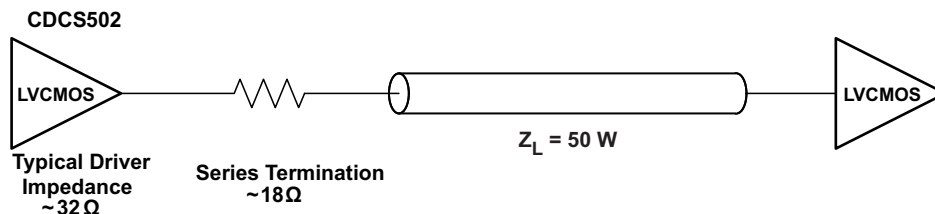


Figure 4. Test Load for 50-Ω Board Environment

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CDCS502PW	ACTIVE	TSSOP	PW	8	150	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CDCS502PWR	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION
REEL DIMENSIONS

TAPE DIMENSIONS


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCS502PWR	TSSOP	PW	8	2000	330.0	12.4	7.0	3.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

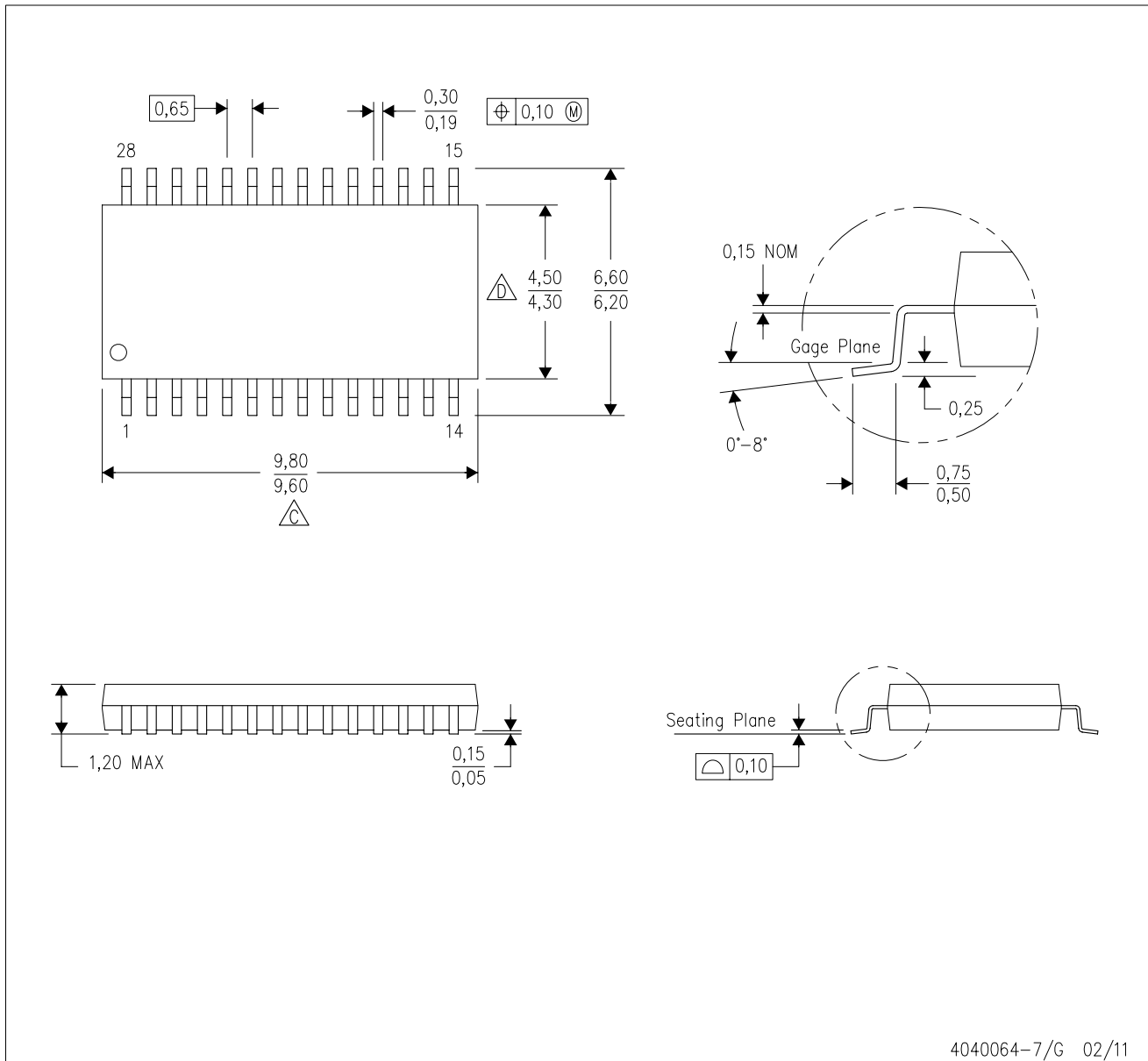


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCS502PWR	TSSOP	PW	8	2000	367.0	367.0	35.0

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE

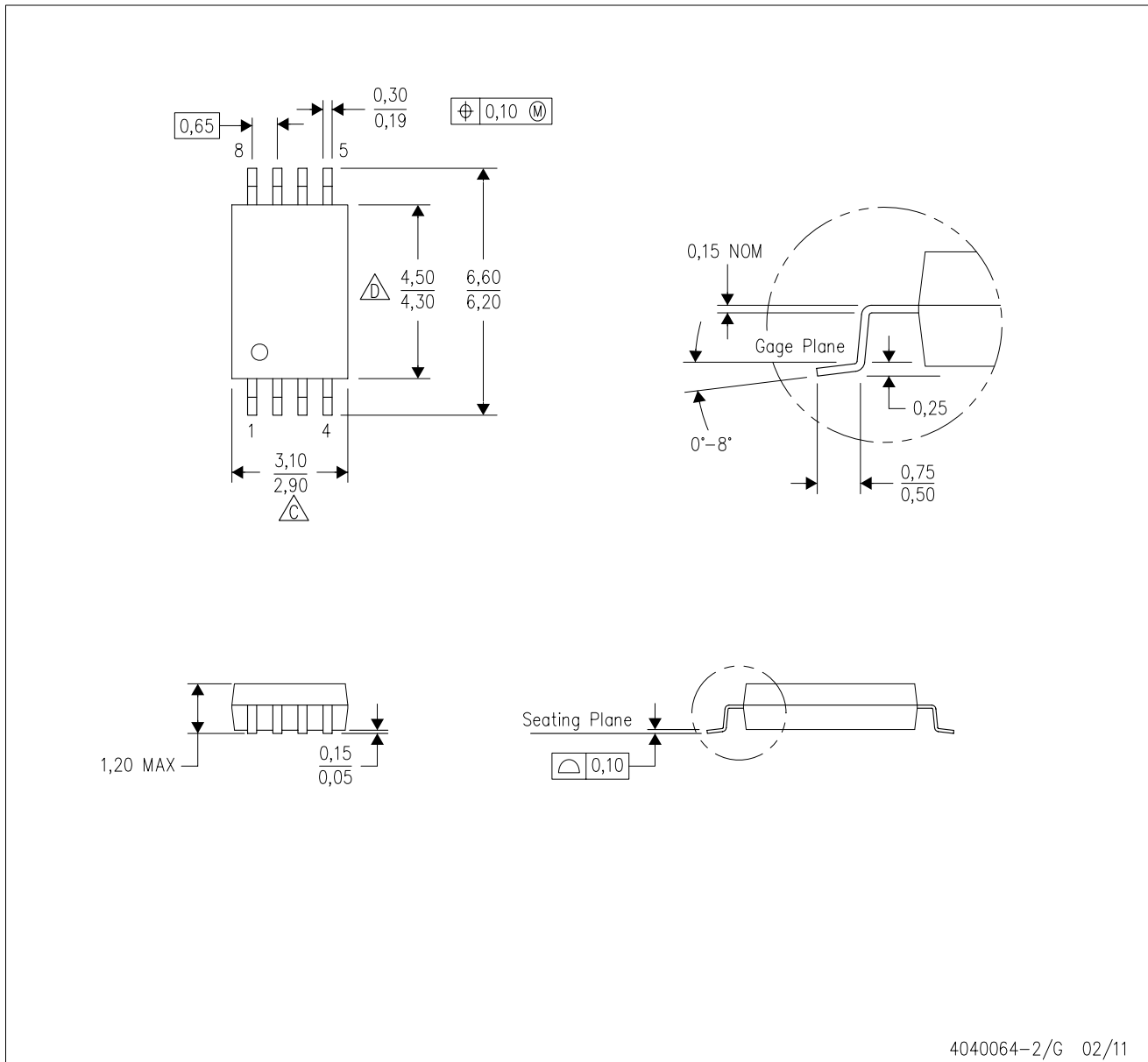


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- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
 - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
 - E. Falls within JEDEC MO-153

PW (R-PDSO-G8)

PLASTIC SMALL OUTLINE



4040064-2/G 02/11

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
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